

SCES122F-JULY 1997-REVISED OCTOBER 2004

FEATURES	
<ul> <li>Member of the Texas Instruments Widebus™ Family</li> </ul>	DGG, DGV, OR DL PACKAGE (TOP VIEW)
<ul> <li>EPIC<sup>™</sup> (Enhanced-Performance Implanted</li> </ul>	
CMOS) Submicron Process	Y1 🛛 2 55 🗍 A1
<ul> <li>Output Port Has Equivalent 26-Ω Series</li> </ul>	Y2 🛛 3 54 🛛 A2
Resistors, So No External Resistors Are	GND 4 53 GND
Required	Y3 5 52 A3
<ul> <li>Designed to Comply With JEDEC 168-Pin and</li> </ul>	Y4 6 51 A4
200-Pin SDRAM Buffered DIMM Specification	
ESD Protection Exceeds 2000 V Per	Y5 8 49 A5
MIL-STD-883, Method 3015; Exceeds 200 V	Y6 9 48 A6
Using Machine Model (C = 200 pF, R = 0)	
Latch-Up Performance Exceeds 250 mA Per	
JESD 17	Y8 12 45 A8 Y9 13 44 A9
Bus Hold on Data Inputs Eliminates the Need	Y10 14 43 A10
for External Pullup/Pulldown Resistors	Y11 15 42 A11
Package Options Include Plastic Shrink	Y12 16 41 A12
Small-Outline (DL), Thin Shrink Small-Outline	Y13 17 40 A13
(DGG), and Thin Very Small-Outline (DGV)	GND 18 39 GND
Packages	Y14 19 38 A14
NOTE: For tape-and-reel order entry, the DGGR package is	Y15 20 37 A15
abbreviated to GR, and the DGVR package is abbreviated	Y16 21 36 A16
to VR.	V <sub>CC</sub> 22 35 V <sub>CC</sub>
	Y17 23 34 A17
DESCRIPTION	Y18 🛛 24 33 🗍 A18
This 20-bit universal bus driver is designed for 1.65-V	GND 🛛 25 32 🗍 GND
to 3.6-V $V_{CC}$ operation.	Y19 🛛 26 31 🗍 A19

NC - No internal connection

30 A20

29 LE

Y20 127

28

The output port includes equivalent 26- $\Omega$  series resistors to reduce overshoot and undershoot.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH162836 is characterized for operation from -40°C to 85°C.

Data flow from A to Y is controlled by the output-enable  $(\overline{OE})$  input. The device operates in the

transparent mode when the latch-enable (LE) input is

low. When  $\overline{LE}$  is high, the A data is latched if the clock (CLK) input is held at a high or low logic level. If  $\overline{LE}$  is high, the A data is stored in the latch/flip-flop on the low-to-high transition of CLK. When  $\overline{OE}$  is high,

the outputs are in the high-impedance state.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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#### **FUNCTION TABLE**

	INPUTS									
ŌĒ	LE	CLK	Α	Y						
Н	Х	Х	Х	Z						
L	L	Х	L	L						
L	L	Х	Н	н						
L	Н	$\uparrow$	L	L						
L	Н	$\uparrow$	Н	н						
L	Н	L or H	Х	Y <sub>0</sub> <sup>(1)</sup>						

(1) Output level before the indicated steady-state input conditions were established

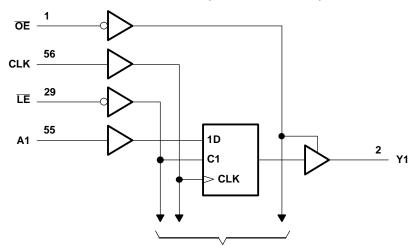
OE CLK LE	1 56 29	•	EN1 > 2C3 C3 G2				
Y1	2		רק קוריים	1	3D	55	A1
	3				30	54	
Y2 Y3	5					52	A2 A3
	6					51	
Y4	8		┣───			49	A4
Y5	9	•				48	A5
Y6	10	•				47	A6
¥7	12	•	<b></b>			45	A7
Y8	13	•	<b> </b>			44	A8
Y9	14	•	<b> </b>			43	A9
Y10	15	•	┣───			42	A10
Y11	16	•	<b> </b>			41	A11
Y12	17	•	└───			40	A12
Y13	19	•	└───			38	A13
Y14	20	•	<b> </b>			37	A14
Y15	21	•	<b> </b>			36	A15
Y16	23	•	1			34	A16
Y17	24	4				33	A17
Y18	26	•				31	A18
Y19	27	◀				30	A19
Y20		•					A20

#### LOGIC SYMBOL<sup>(1)</sup>

(1) This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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#### LOGIC DIAGRAM (POSITIVE LOGIC)



To 19 Other Channels

#### **ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	4.6	V
VI	Input voltage range <sup>(2)</sup>		-0.5	4.6	V
Vo	Output-voltage range <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current	· ·		±50	mA
	Continuous current through each $V_{CC}$ or	GND		±100	mA
		DGG package		81	
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	DGV package		86	°C/W
		DL package		74	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) This value is limited to 4.6 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51.

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#### **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		1.65	3.6	V
		$V_{CC}$ = 1.65 V to 1.95 V	$0.65  imes V_{CC}$		
V <sub>IH</sub>	High-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.7		V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		
		$V_{CC}$ = 1.65 V to 1.95 V		$0.35 \times V_{CC}$	
V <sub>IL</sub>	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		0.7	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	
VI	Input voltage		0	V <sub>CC</sub>	V
Vo	Output voltage		0	V <sub>CC</sub>	V
		$V_{CC} = 1.65 V$		-2	
	Llich lovel output ourrest	$V_{CC} = 2.3 V$		-6	~ ^
I <sub>OH</sub>	High-level output current	$V_{CC} = 2.7 V$		-8	mA
		$V_{CC} = 3 V$		-12	
		V <sub>CC</sub> = 1.65 V		2	
	Low lovel output ourrept	$V_{CC} = 2.3 V$		6	mA
I <sub>OL</sub>	Low-level output current	$V_{CC} = 2.7 V$		8	ША
		$V_{CC} = 3 V$		12	
$\Delta t/\Delta v$	Input transition rise or fall rate			10	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

(1) All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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#### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup> MAX	UNIT
	I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2		
	I <sub>OH</sub> = -2 mA	1.65 V	1.2		
	I <sub>OH</sub> = -4 mA	2.3 V	1.9		
V <sub>OH</sub>	1 – 6 m A	2.3 V	1.7		V
	I <sub>OH</sub> = -6 mA	3 V	2.4		
	I <sub>OH</sub> = -8 mA	2.7 V	2		
	I <sub>OH</sub> = -12 mA	3 V	2		
	I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V		0.2	
	I <sub>OL</sub> = 2 mA	1.65 V		0.45	
	$I_{OL} = 4 \text{ mA}$	2.3 V		0.4	
V <sub>OL</sub>		2.3 V		0.55	V
	I <sub>OL</sub> = 6 mA	3 V		0.55	
	I <sub>OL</sub> = 8 mA	2.7 V		0.6	
	I <sub>OL</sub> = 12 mA	3 V		0.8	
I <sub>I</sub>	$V_1 = V_{CC}$ or GND	3.6 V		±5	μA
	V <sub>1</sub> = 0.58 V	1.65 V	25		
	V <sub>1</sub> = 1.07 V	1.65 V	-25		
	V <sub>1</sub> = 0.7 V	2.3 V	45		
I <sub>I(hold)</sub>	V <sub>1</sub> = 1.7 V	2.3 V	-45		μA
	V <sub>1</sub> = 0.8 V	3 V	75		
	V <sub>1</sub> = 2 V	3 V	-75		
	$V_1 = 0$ to 3.6 V <sup>(2)</sup>	3.6 V		±500	
l <sub>oz</sub>	$V_0 = V_{CC}$ or GND	3.6 V		±10	μA
I <sub>CC</sub>	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	3.6 V		40	μA
Δl <sub>CC</sub>	One input at $V_{CC}$ - 0.6 V, Other inputs at $V_{CC}$ or GND	3 V to 3.6 V		750	μA
C Control inputs		221/		5.5	~F
C <sub>i</sub> Data inputs	$V_1 = V_{CC}$ or GND	3.3 V		6	pF
C <sub>o</sub> Outputs	$V_0 = V_{CC}$ or GND	3.3 V		8	pF

(1) All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . (2) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

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#### TIMING REQUIREMENTS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1 through Figure 3)

				V <sub>CC</sub> =	1.8 V	V <sub>CC</sub> = ± 0.	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 3 ± 0.3	3.3 V 8 V	UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency				(1)		150		150		150	MHz
	Dulas duration	LE low		(1)		3.3		3.3		3.3		
t <sub>w</sub>	Pulse duration	CLK high or low	CLK high or low			3.3		3.3		3.3		ns
		Data before CLK↑		(1)		1.4		1.7		1.5		
t <sub>su</sub>	Setup time	Data before LE↑	CLK high	(1)		1.2		1.6		1.3		ns
		Data before LE	CLK low	(1)		1.4		1.5		1.2		
	Data after CLK1			(1)		0.9		0.9		0.9		
t <sub>h</sub>	Hold time	Data after LE↑	CLK high or low	(1)		1.1		1.1		1.1		ns

(1) This information was not available at the time of publication.

#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1 through Figure 3)

PARAMETER	FROM	TO	V <sub>CC</sub> = 1	1.8 V	V <sub>CC</sub> = 2 ± 0.2	2.5 V 2 V	V <sub>CC</sub> = 2	2.7 V	V <sub>CC</sub> = 3 ± 0.3	3.3 V 3 V	UNIT
	(INPUT)	(OUTPUT)	MIN	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			(1)		150		150		150		MHz
	А			(1)	1	4.4		4.6	1.2	4	
t <sub>pd</sub>	LE	Y		(1)	1.1	5.8		6.1	1.4	5.1	ns
	CLK			(1)	1	5.2		5.5	1.1	5	
t <sub>en</sub>	OE	Y		(1)	1.1	6.4		6.5	1.2	5.5	ns
t <sub>dis</sub>	ŌĒ	Y		(1)	1	4.7		5.2	1.7	5.1	ns

(1) This information was not available at the time of publication.

### **OPERATING CHARACTERISTICS**

 $T_A = 25^{\circ}C$ 

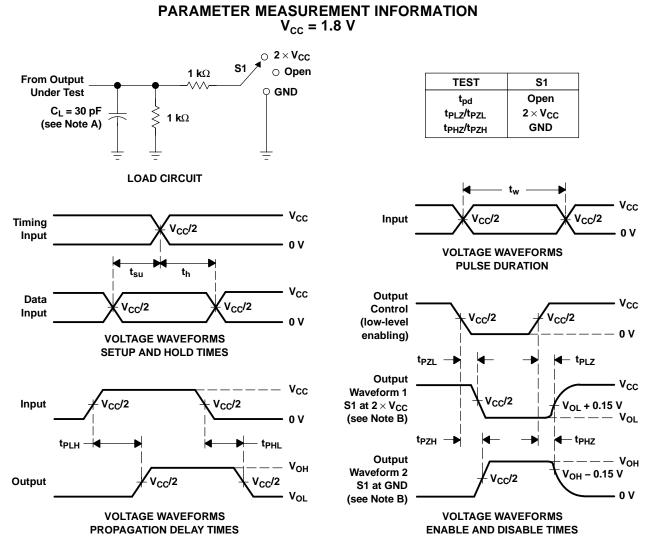
	PARAMET	ER	TEST	CONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT
<u> </u>	Power dissipation	Outputs enabled	<b>C</b> 0	f - 10 MHz	(1)	31.5	36	۰L
C <sub>pd</sub>	capacitance	Outputs disabled	$C_L = 0,$	f = 10 MHz	(1)	8	10.5	pF

(1) This information was not available at the time of publication.

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### SN74ALVCH162836 20-BIT UNIVERSAL BUS DRIVER WITH 3-STATE OUTPUTS

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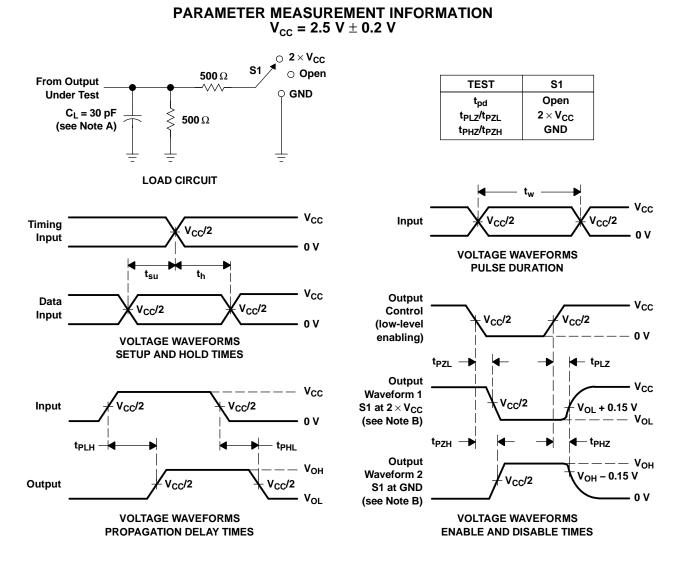


- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

#### Figure 1. Load Circuit and Voltage Waveforms



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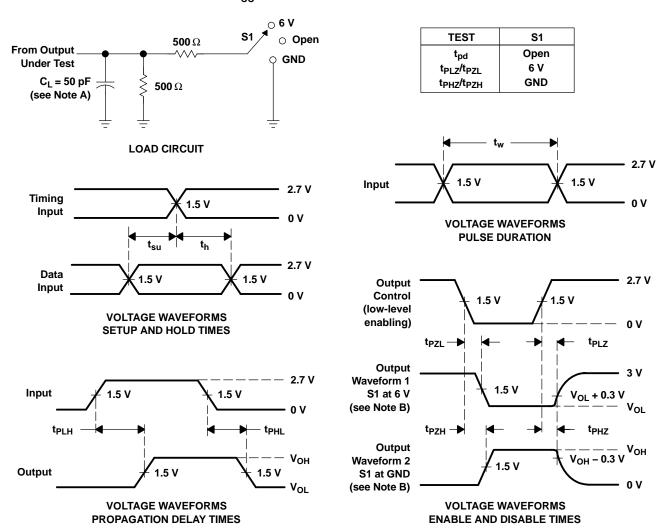
- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
  - G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

#### Figure 2. Load Circuit and Voltage Waveforms



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# PARAMETER MEASUREMENT INFORMATION $V_{cc}$ = 2.7 V AND 3.3 V $\pm$ 0.3 V



- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
    C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω, t<sub>r</sub> ≤ 2.5 ns, t<sub>f</sub> ≤ 2.5 ns.
    D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ} \, \text{and} \, t_{PHZ} \, \text{are the same as} \, t_{dis}.$
  - F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
  - G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.

Figure 3. Load Circuit and Voltage Waveforms



#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ALVCH162836GR	ACTIVE	TSSOP	DGG	56	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH162836	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

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<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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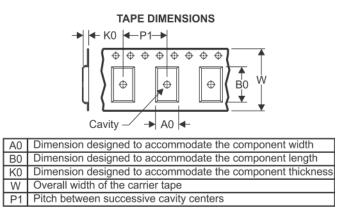
## PACKAGE MATERIALS INFORMATION

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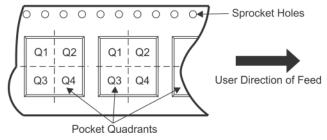
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#### **TAPE AND REEL INFORMATION**





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal				
Device	Package	Package	Pins	SPQ

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVCH162836GR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1

TEXAS INSTRUMENTS

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## PACKAGE MATERIALS INFORMATION

12-Aug-2013



\*All dimensions are nominal

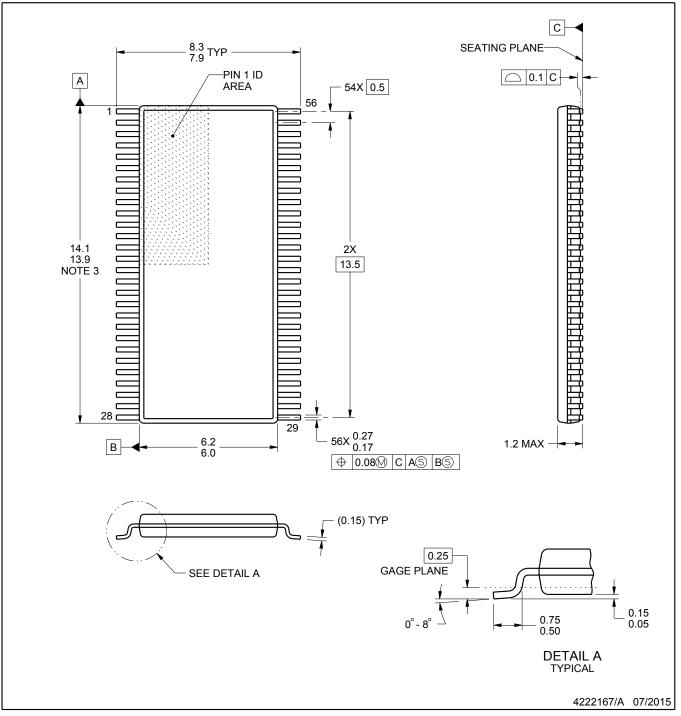
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALVCH162836GR	TSSOP	DGG	56	2000	367.0	367.0	45.0

## **PACKAGE OUTLINE**

## **DGG0056A**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not

- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-153.

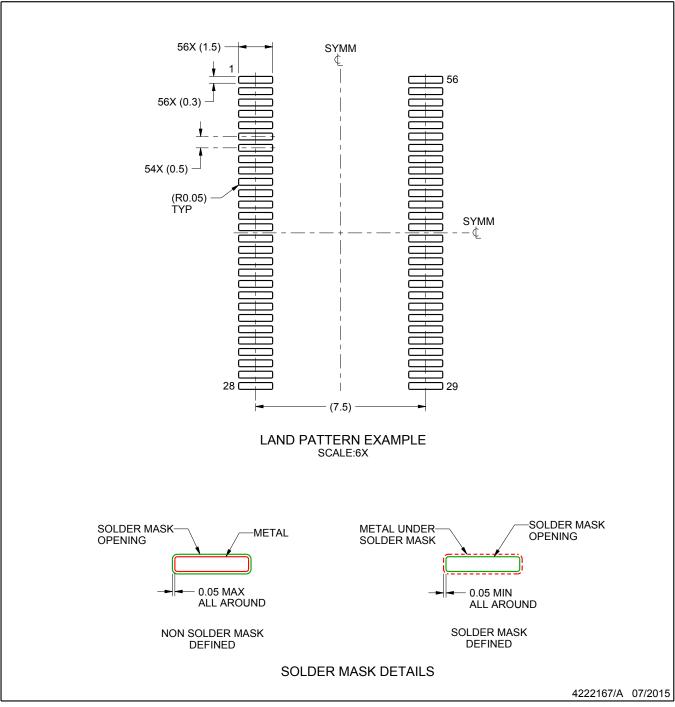


## DGG0056A

## **EXAMPLE BOARD LAYOUT**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

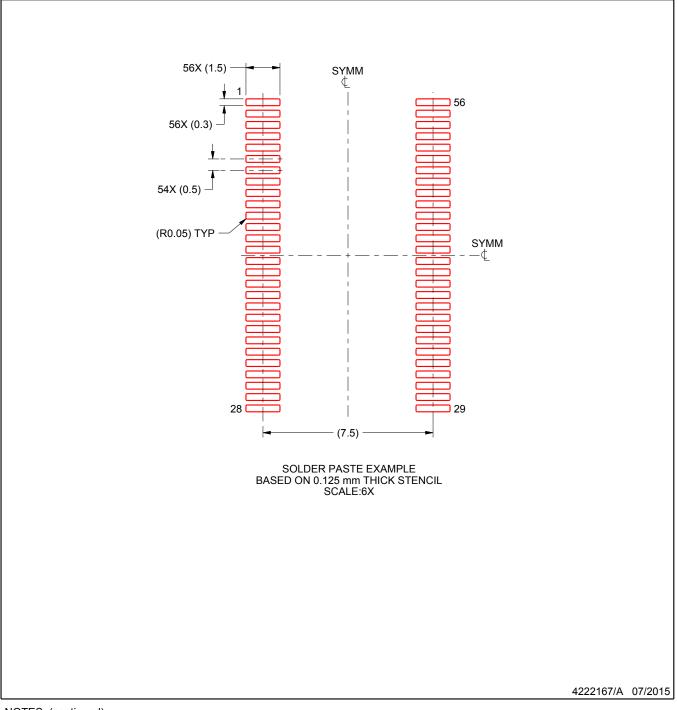


## DGG0056A

## **EXAMPLE STENCIL DESIGN**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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